Search Notes

App	lica	tion/Contro	l No.

10/517,143 Examiner

Applicant(s)/Patent under Reexamination

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HIGASHIDA, MASASHITO

Art Unit

Nathan Wiehe

3745

SEARCHED				
Class	Subclass	Date	Examiner	
415	203,204, 205,228	5/24/2006	NEW	
416	189	5/24/2006	new	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NC (INCLUDING SEARCH)
	DATE	EXMR
415/203,204,205,228 416/189 Ninh Nguyen	5/24/2006	NEW
Text Search (See EAST Search History)	5/24/2006	NEW
Inventor Name Search	5/24/2006	NEW